Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/716,556	IGUCHI ET AL.	
Examiner	Art Unit	
Jack Chen	2813	

Subclass	Date **Physics**	Examiner
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Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated	4/18/05	JC		
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